

Search Notes

Application/Control No.

10/782,481

Examiner

James D. Stein

Applicant(s)/Patent under
Reexamination

TELKAMP ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	17,42,131	9/7/2005	JDS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	9/7/2005	JDS
385/14-52,129 -- Keyword search	9/7/2005	JDS
IEEE and INSPEC: matrix, switch, waveguide, plane, layer, parallel, perpendicular	9/7/2005	JDS